Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/556,226	CHUNG ET AL.
Examiner	Art Unit
Tuyet Vo	2821

SEARCHED			
Class	Subclass	Date	Examiner
250	396R	12/4/2006	₹>
	398	12/4/2006	
	374	12/5/2006	
V	379	12/5/2006	
315 1	111.21	12/4/2006	
	111.71	12/4/2006	V

INTERFERENCE SEARCHED						
Cla	iss	Subclass	Date		Examiner	
25	50 \	396R	12/5/2006		ΤV	
		374				
V	/	379	\			/
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
(250/396R,398,400,374,379; 315/111.21,111.71,111.01) combined with electrodes, dielectric/insulated panel/layer	12/4/2006	TV
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